

Component & Device Parameter Test Instruments

I. TH2840 Series Precision LCR Meter

Features

- The test speed is as high as 1800 times/s (>10kHz), without relay action time
- Test level up to 20Vrms
- The bias voltage is built-in $\pm 40V/\pm 100mA/2A$
- Industry-friendly user experience: Linux bottom layer, built-in help file
- 10.1 inch 1280×800 capacitive touch screen
- Approximately 100M setting file storage space in the machine, and massive U disk setting file storage capacity
- Provide host computer to support early model file format conversion to ensure compatibility



RS232	USB HOST	USB DEVICE	HANDLER	LAN	EXTERNAL DCI
standard	standard	standard	standard	standard	standard

Dimension: 430mm(W)x177mm(H)x265mm(D)

Weight: 11kg

Applications

■ Passive component:

Impedance parameter estimation and performance analysis of capacitor, inductor, magnetic core, resistor, piezoelectric devices, transformers, chip components and network components

■ Semiconductor component

Parasitic parameter test and analysis of LED driver integrated circuit C-VDC features of varactors

Parasitic parameter analysis of transistors or integrated circuit

■ Other components

Impedance assessment of printed circuit boards, relays, switches, cables, batteries

■ Dielectric material

Dielectric constant and loss angle evaluation of plastics, ceramics and other materials

■ Magnetic materials

Magnetic permeability and loss angle assessment of ferrite, amorphous body and other magnetic materials

■ Semiconductor materials

Dielectric constant, electrical conductivity and C-V characteristics of semiconductor materials

■ Liquid crystal cell

Dielectric constant, elastic constant and C-V characteristics of liquid crystal cell

Specifications

Model		TH2840A	TH2840B
Display	Display	10.1" Touch Screen	
	Ratio	16:9	
	Resolution	1280×RGB×800	
Parameter	Test Mode	Four Parameter Selectable	
	AC	Cp/Cs, Lp/Ls, Rp/Rs, Z , Y , R, X, G, B, θ , D, Q, V_{AC} , I_{AC}	
	DC	R_{DC} , V_{DC} , I_{DC}	
Frequency	Range	20Hz-500kHz	20Hz-2MHz
	Accuracy	0.01%	
	Resolution	0.1mHz (20.0000Hz-99.9999Hz)	
		1mHz (100.000Hz-999.999Hz)	
		10mHz (1.00000kHz-9.99999kHz)	
		100mHz (10.0000kHz-99.9999kHz)	
		1Hz (100.000kHz-999.999kHz)	
		10Hz (1.00000MHz-2.00000MHz)	
AC test signal mode	Rated value (ALC OFF)	Set the voltage as the Hcur voltage when the test terminal is open Set the current to be the current flowing from Hcur when the test terminal is short-circuited	
	Constant value (ALC ON)	Keep the voltage on the DUT the same as the set value Keep the current on the DUT the same as the set value	

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Test Level	AC Voltage	5mVrms-20Vrms	F≤1MHz 5mVrms-20Vrms F > 1MHz 5mVrms-15Vrms
	Accuracy	± (10%×Set Value+2mV) (AC less than 2Vrms) ± (10%×Set Value+5mV) (AC > 2Vrms)	
	Resolution	1mVrms (5mVrms-0.2Vrms)	
		1mVrms (0.2Vrms-0.5Vrms)	
		1mVrms (0.5Vrms-1Vrms)	
		10mVrms (1Vrms-2Vrms)	
		10mVrms (2Vrms-5Vrms)	
		10mVrms (5Vrms-10Vrms)	
		10mVrms (10Vrms-20Vrms)	
	AC Current	50μArms-100mArms	
	Resolution(100Ω Internal Resistance)	10μArms (50μArms-2mArms)	
		10μArms (2mArms-5mArms)	
		10μArms (5mArms-10mArms)	
		100μArms (10mArms-20mArms)	
		100μArms (20mArms-50mArms)	
		100μArms (50mArms-100mArms)	
R _{DC} Test	Voltage	100mV-20V	
	Resolution	1mV (0V-1V) 10mV (1V-20V)	
DC Bias	Voltage	0V-±40V	
	Accuracy	AC≤2V 1%×Set Value+5mV AC>2V 2%×Set Value+8mV	
	Resolution	1mV (0V-1V) 10mV (±1V- ±40V)	
	Current	0mA-±100mA	
	Resolution	10μA (0mA-10mA) 100μA (10mA-100mA)	
Built-in current source	Current	0mA-2A	
	Accuracy	I>5mA ± (2%×Set Value+2mA)	
	Resolution	1mA	
Test terminal configuration		Four Terminal Pair	
Test cable length		0m	
Output impedance		30Ω, ±4%@1kHz 100Ω, ±2%@1kHz	
computation		The absolute deviation from the nominal value Δ, the percentage deviation from the nominal value Δ%	
Equivalent way		Series, Parallel	
Calibration function		OPEN, SHORT, LOAD	
Measurement average		1-255	
Range selection		AUTO, HOLD	
Range configuration	LCR	100mΩ, 1Ω, 10Ω, 20Ω, 50Ω, 100Ω, 200Ω, 500Ω, 1kΩ, 2kΩ, 5kΩ, 10kΩ, 20kΩ, 50kΩ, 100kΩ	
	R _{DC}	1Ω, 10Ω, 20Ω, 50Ω, 100Ω, 200Ω, 500Ω, 1kΩ, 2kΩ, 5kΩ, 10kΩ, 20kΩ, 50kΩ, 100kΩ	
Measuring time (ms)		Fast+: 0.56ms (1800 times/s) Fast: 3.3ms Middle: 90ms Slow: 220ms	
Highest accuracy		0.05% (refer to the instruction manual for details)	
Measurement display range			
Cs, Cp		0.00001pF-9.99999F	
Ls, Lp		0.00001μH-99.9999kH	
D		0.00001-9.99999	
Q		0.00001-99999.9	
R, Rs, Rp, X, Z, R _{DC}		0.001mΩ-99.9999MΩ	
G, B, Y		0.00001μS-99.9999S	
V _{DC}		±0V-±999.999V	
I _{DC}		±0A-±999.999A	

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θ_r		-3.14159-3.14159
θ_d		-179.999°-179.999°
$\Delta\%$		$\pm (0.000\%-999.9\%)$
Multi-function parameter list scan	Dots Number	201 points, average times can be set for each point, and each point can be sorted separately
	Parameter	Test frequency, AC voltage, AC current, DC BIAS voltage, DC BIAS current (100mA), DC BIAS current (2A)
	Trigger mode	Sequence SEQ: After a trigger, measure at all sweep points, and /EOM/INDEX will output only once Step STEP: Perform a sweep point measurement each time it is triggered, and each point outputs /EOM/INDEX, but the list sweep comparator result is only output at the last /EOM
	Other features	1.Scan parameters and test parameters have multiple copy functions 2.Delay can be set for each scan point
	Comparators	Each sweep point can measure up to four test parameters, each parameter can set upper and lower limits, all test parameters are qualified, output PASS signal, otherwise output FAIL signal, no upper and lower limits are set, no judgment
Graphic scan	Scan points	51, 101, 201, 401, 801 Optional
	The results	The extreme value of each parameter and the sweep parameter value at the point where the cursor is located and the corresponding test parameter value
	Scan trajectory	1-4 test parameters can be selected arbitrarily, the scanning curve can be divided into one screen, two screens, or four screens
	Display range	Real-time automatic, locked
	Coordinate ruler	Logarithmic, linear
	Scan parameters	Frequency, AC voltage, AC current, DCV BIAS / DCI BIAS (100mA) / DCI BIAS (2A)
	Trigger mode	single continuous
Comparators	Results save	Graphics, files
	Bin	10Bin, PASS, FAIL
	Bin deviation setting	Deviation value, percentage deviation value, off
	Bin mode	Tolerance, continuous
	Bin count	0-99999
	Discrimination	Up to four parameter limit ranges can be set for each file. The corresponding file number is displayed within the setting range of the four test parameter results. If the maximum file number range is exceeded, FAIL is displayed. The test parameters without the upper and lower limits are automatically ignored.
PASS/FAIL indication		Meet Bin1-10, the PASS light on the front panel is on, otherwise the FAIL light
Data cache		201 measurement results can be read in batches
Store call	Inside	About 100M non-volatile memory test setting file
	External USB	Test setting file, screenshot graph, record file
Keyboard lock		The front panel keys can be locked, other functions to be expanded
Interface	USB HOST	2 USB HOST ports, can connect mouse and keyboard at the same time, only one U disk can be used at the same time
	USB DEVICE	Universal serial bus socket, small type B (4 contact positions); compatible with USB TMC-USB488 and USB2.0, the female connector is used to connect an external controller.
	LAN	10/100M Ethernet adaptive
	HANDLER	Used for Bin signal output
	External DC BIAS control	Support TH1778A
	RS232C	Standard 9-pin, cross
RS485		Can accept modification or external RS232 to RS485 module
Power-on warm-up time		60 Minutes
Input voltage		100-120VAC/198-242VAC Option, 47-63Hz
Power consumption		More than 130VA
Size (WxHxD) mm ³		430x177x265
Weight (kg)		11kg